

# 6N137 OPTOCOUPLER/OPTOISOLATOR

SOOS003 D291B, JULY 1986

- Gallium Arsenide Phosphide LED Optically Coupled to Integrated Circuit Detector
- Compatible with TTL and LSTTL Inputs
- Low Input Current Required to Turn Output On . . . 5 mA Max
- High-Voltage Electrical Insulation . . . 3000 V DC Min
- High-Speed Switching . . . 75 ns Max
- Plastic Dual-In-Line Package
- UL Recognized . . . File Number 65085

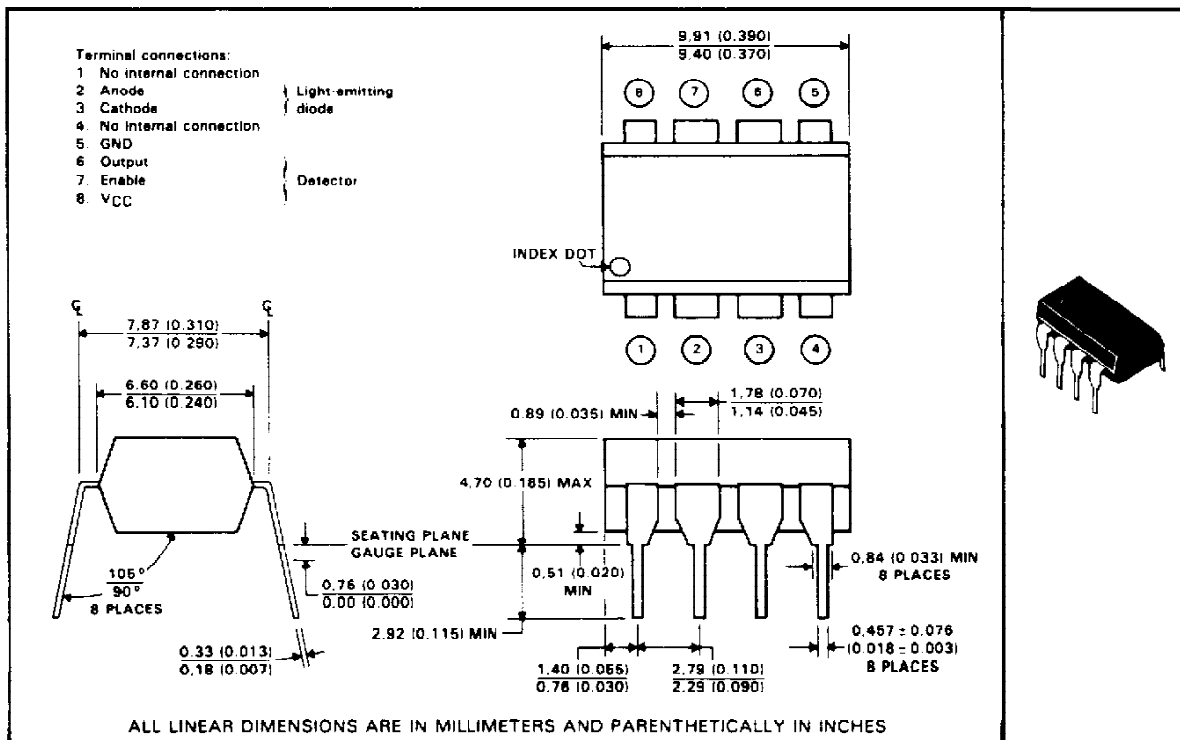
## description

The 6N137 optocoupler is designed for use in high-speed digital interfacing applications that require high-voltage isolation between the input and output. Applications include line receivers, microprocessors or computer interface, digital programming of floating power supplies, motors, and other control systems.

The 6N137 high-speed optocoupler consists of a GaAsP light-emitting diode and an integrated light detector composed of a photodiode, a high-gain amplifier, and a Schottky-clamped open-collector output transistor. An input diode forward current of 5 milliamperes will switch the output transistor low, providing an on-state drive current of 13 milliamperes (eight 1.6-milliampere TTL loads). A TTL-compatible enable input is provided for applications that require output-transistor gating.

The 6N137 is characterized for operation over the temperature range of 0°C to 70°C.

## \*mechanical data



\*JEDEC registered data. This data sheet contains all applicable registered data in effect at the time of publication.

PRODUCTION DATA documents contain information current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

**TEXAS  
INSTRUMENTS**

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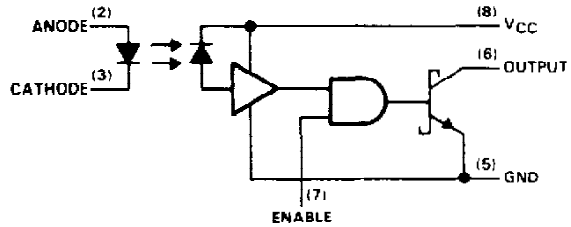
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**FUNCTION TABLE**

INPUT	ENABLE	OUTPUT
I <sub>F(on)</sub>	H	L
I <sub>F(off)</sub>	X	H
X	L	H

**logic diagram (positive logic)**



**\*absolute maximum ratings over operating free-air temperature range (unless otherwise noted)**

Supply voltage, V <sub>CC</sub>	7 V
Reverse input voltage	5 V
Enable input voltage (not to exceed V <sub>CC</sub> by more than 500 mV)	5.5 V
Output voltage	7 V
Peak forward input current (≤ 1 ms duration) (TI-guaranteed value)	40 mA
(JEDEC-registered value)	20 mA
Average forward input current (TI-guaranteed value)	20 mA
(JEDEC-registered value)	10 mA
Output current	50 mA
Output power dissipation	85 mW
Storage temperature range	-55 °C to 125 °C
Operating free-air temperature range	0 °C to 70 °C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260 °C

\*JEDEC registered data

**recommended operating conditions**

	MIN	NOM	MAX	UNIT
V <sub>CC</sub> Output supply voltage (see Note 1)	4.5	5	5.5	V
V <sub>IH(EN)</sub> High-level enable input voltage (see Note 2)	2		V <sub>CC</sub>	V
V <sub>IL(EN)</sub> Low-level enable input voltage	0		0.8	V
I <sub>F(on)</sub> Input forward current to turn output on	6.3		15	mA
I <sub>F(off)</sub> Input forward current to turn output off	0		250	μA
I <sub>OL</sub> Low-level (on-state) output current			13	mA
T <sub>A</sub> Operating free-air temperature	0		70	°C

- NOTES: 1. All voltage values are with respect to GND (pin 5).  
 2. No external pullup is required at the enable input; an open circuit will establish the high level.

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP†	MAX	UNIT
*V <sub>F</sub> Input forward voltage	I <sub>F</sub> = 10 mA, T <sub>A</sub> = 25°C		1.6	1.75	V
αV <sub>F</sub> Temperature coefficient of forward voltage	I <sub>F</sub> = 10 mA		-1.8		mV/°C
*V <sub>BR</sub> Input reverse breakdown voltage	I <sub>R</sub> = 10 μA, T <sub>A</sub> = 25°C	5			V
*V <sub>OL</sub> Low-level output voltage	V <sub>CC</sub> = 5.5 V, V <sub>I(EN)</sub> = 2 V, I <sub>F</sub> = 5 mA, I <sub>OL</sub> = 13 mA		0.23	0.6	V
*I <sub>OH</sub> High-level output current	V <sub>CC</sub> = 5.5 V, V <sub>O</sub> = 5.5 V, V <sub>I(EN)</sub> = 2 V, I <sub>F</sub> = 250 μA			250	μA
I <sub>H(EN)</sub> High-level enable input current	V <sub>CC</sub> = 5.5 V, V <sub>I(EN)</sub> = 2 V		-0.2		mA
*I <sub>L(EN)</sub> Low-level enable input current	V <sub>CC</sub> = 5.5 V, V <sub>I(EN)</sub> = 0.5 V		-0.5	-2	mA
*I <sub>CCH</sub> Supply current, high-level output	V <sub>CC</sub> = 5.5 V, V <sub>I(EN)</sub> = 0.5 V, I <sub>F</sub> = 0		10	15	mA
*I <sub>CCL</sub> Supply current, low-level output	V <sub>CC</sub> = 5.5 V, V <sub>I(EN)</sub> = 0.5 V, I <sub>F</sub> = 10 mA		13	18	mA
*I <sub>IO</sub> Input-output insulation leakage current	V <sub>IO</sub> = 3000 V, t = 5 s, T <sub>A</sub> = 25°C, RH = 45%, See Note 1			1	μA
r <sub>IO</sub> Input-output resistance	V <sub>IO</sub> = 500 V, T <sub>A</sub> = 25°C, See Note 1		10 <sup>12</sup>		Ω
C <sub>i</sub> Input capacitance	V <sub>F</sub> = 0, f = 1 MHz		60		pF
C <sub>IO</sub> Input-output capacitance	f = 1 MHz, T <sub>A</sub> = 25°C, See Note 1		0.6		pF

\*JEDEC registered data

† All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C

NOTE 1: These parameters are measured between pins 2 and 3 shorted together and pins 5, 6, 7, and 8 shorted together.

switching characteristics at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C

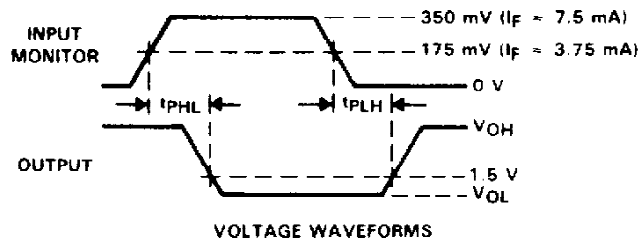
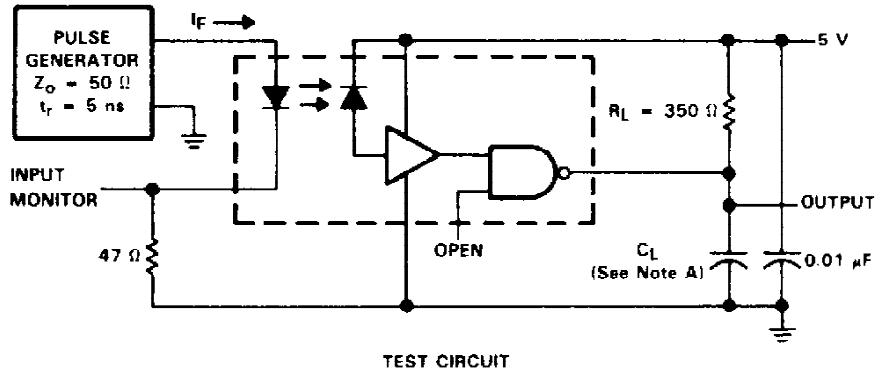
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
*t <sub>PLH</sub> Propagation delay time, low-to-high-level output, from LED input	I <sub>F</sub> = 7.5 mA, R <sub>L</sub> = 350 Ω, C <sub>L</sub> = 15 pF, See Figure 1		42	75	ns
*t <sub>PHL</sub> Propagation delay time, high-to-low level output, from LED input	I <sub>F</sub> = 7.5 mA, R <sub>L</sub> = 350 Ω, C <sub>L</sub> = 15 pF, See Figure 1		42	75	ns
t <sub>PLH(EN)</sub> Propagation delay time, low-to-high level output, from enable	I <sub>F</sub> = 7.5 mA, R <sub>L</sub> = 350 Ω, C <sub>L</sub> = 15 pF, See Figure 2		40		ns
t <sub>PHL(EN)</sub> Propagation delay time, high-to-low-level output, from enable	I <sub>F</sub> = 7.5 mA, R <sub>L</sub> = 350 Ω, C <sub>L</sub> = 15 pF, See Figure 2		25		ns
t <sub>r</sub> Rise time	I <sub>F</sub> = 7.5 mA, R <sub>L</sub> = 350 Ω, C <sub>L</sub> = 15 pF		20		ns
t <sub>f</sub> Fall time	I <sub>F</sub> = 7.5 mA, R <sub>L</sub> = 350 Ω, C <sub>L</sub> = 15 pF		30		ns
$\frac{dV_{CM}}{dt}$ (H) Common mode input transient immunity, high-level output	ΔV <sub>CM</sub> = 10 V, I <sub>F</sub> = 0, R <sub>L</sub> = 350 Ω, See Note 2 and Figure 3		50		V/μs
$\frac{dV_{CM}}{dt}$ (L) Common-mode input transient immunity, low-level output	ΔV <sub>CM</sub> = -10 V, I <sub>F</sub> = 5 mA, R <sub>L</sub> = 350 Ω, See Note 2 and Figure 3		-150		V/μs

\*JEDEC registered data

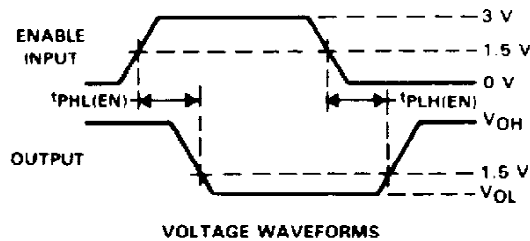
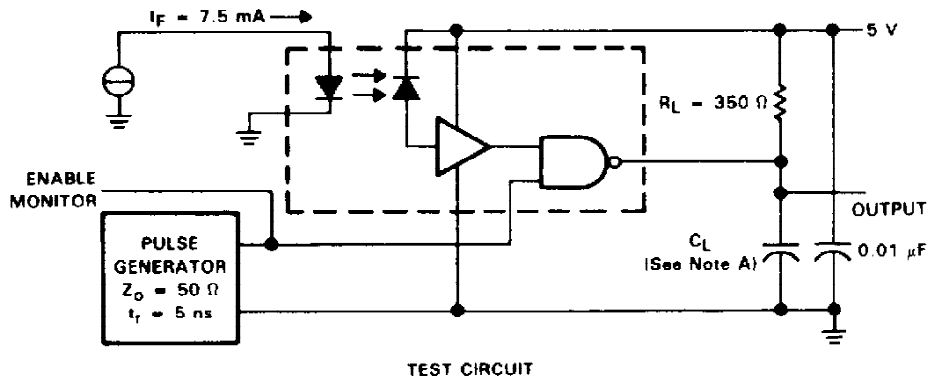
NOTE 2: Common-mode input transient immunity, high-level output, is the maximum rate of rise of the common-mode input voltage that does not cause the output voltage to drop below 2 V. Common-mode input transient, low-level output, is the maximum rate of fall of the common-mode input voltage that does not cause the output voltage to rise above 0.8 V.

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**PARAMETER MEASUREMENT INFORMATION**



**FIGURE 1. t<sub>PLH</sub> AND t<sub>PHL</sub> FROM LED INPUT TEST CIRCUIT AND WAVEFORMS**



**FIGURE 2. t<sub>PLH(EN)</sub> AND t<sub>PHL(EN)</sub> FROM ENABLE TEST CIRCUIT AND WAVEFORMS**

NOTE A: C<sub>L</sub> is approximately 15 pF, which includes probe and stray wiring capacitances.

PARAMETER MEASUREMENT INFORMATION

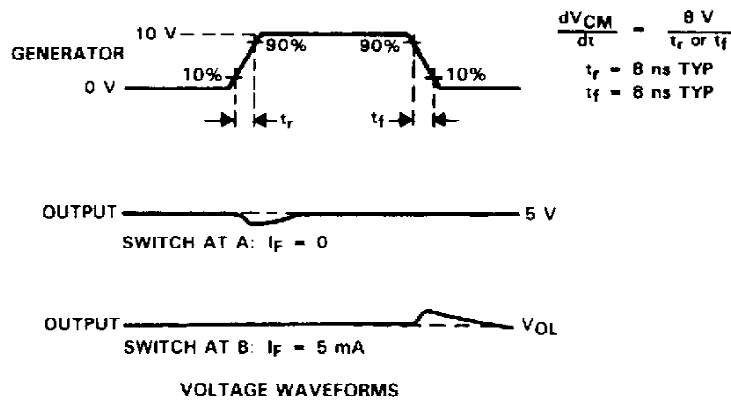
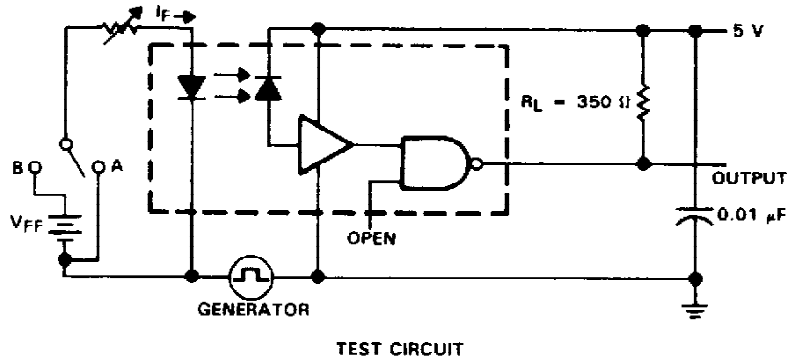


FIGURE 3. TRANSIENT IMMUNITY TEST CIRCUIT AND WAVEFORMS

TYPICAL APPLICATION INFORMATION

A ceramic capacitor (0.01  $\mu\text{F}$  to 0.1  $\mu\text{F}$ ) should be connected between pins 8 and 5 to stabilize the high-gain amplifier. The total lead length between the capacitor and the optocoupler should not exceed 20 mm (0.8 inches). Failure to provide a bypass capacitor may result in impaired switching characteristics.

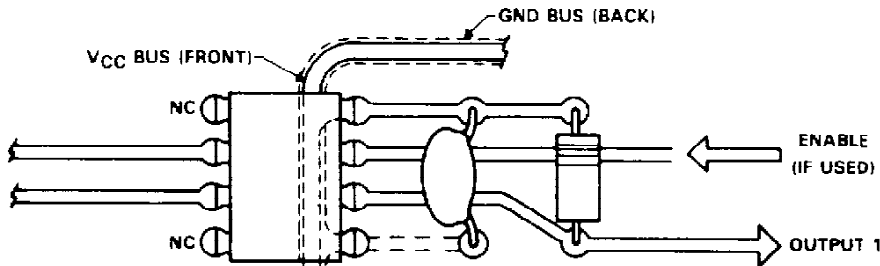


FIGURE 4. RECOMMENDED PRINTED CIRCUIT BOARD LAYOUT

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**TYPICAL CHARACTERISTICS**

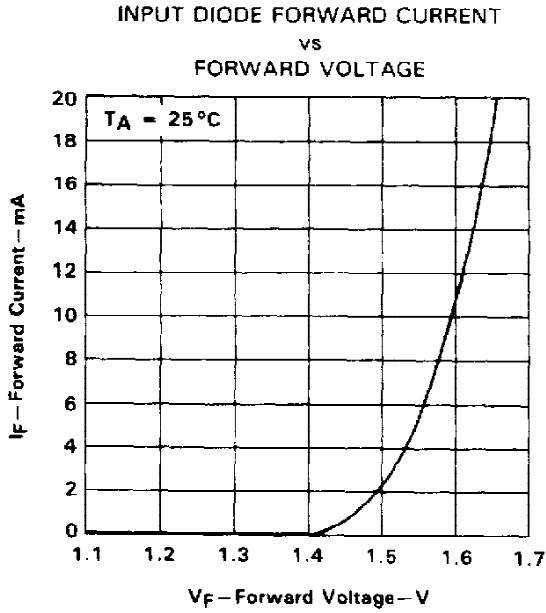


FIGURE 5

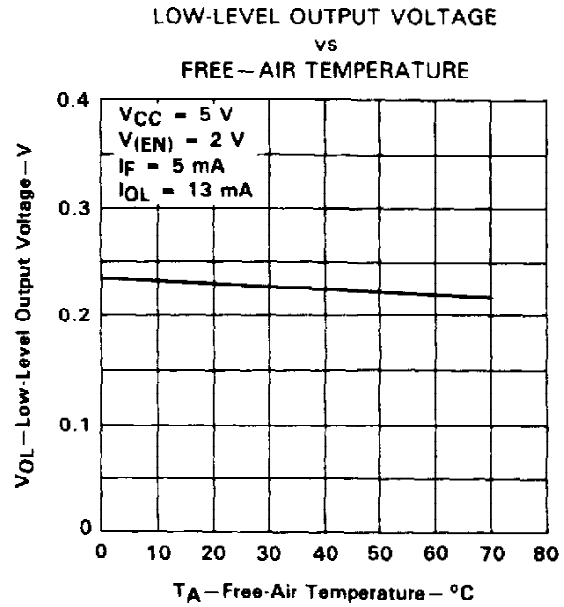


FIGURE 6

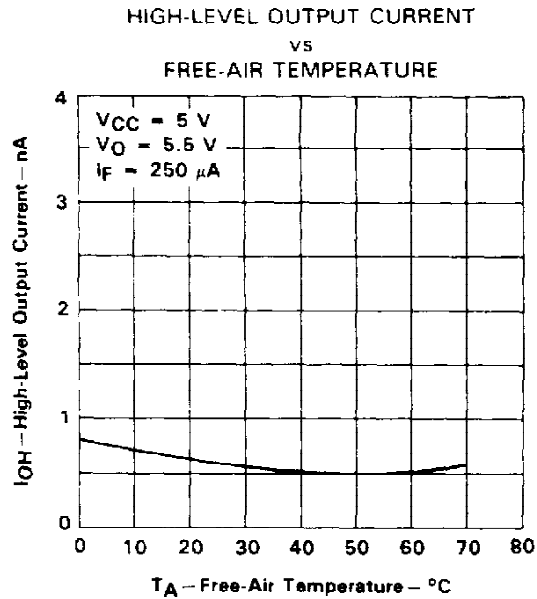


FIGURE 7

TYPICAL CHARACTERISTICS

PROPAGATION DELAY TIME FROM LED INPUT  
vs  
PULSE FORWARD CURRENT

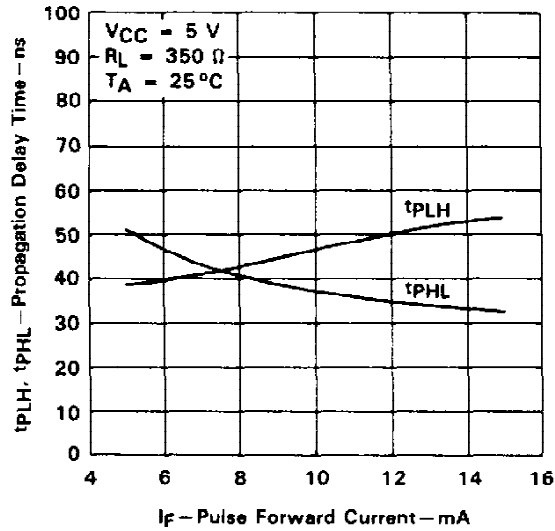


FIGURE 8

PROPAGATION DELAY TIME FROM LED INPUT  
vs  
LOAD RESISTANCE

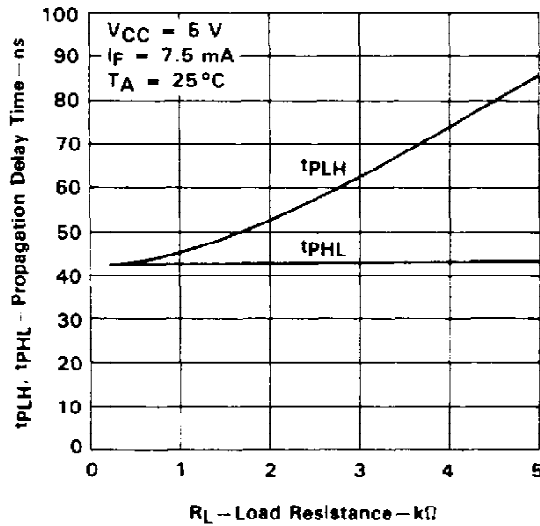


FIGURE 9

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